# MT100N06

# N-Channel Enhancement Mode Field Effect Transistor

# **General Description**

These N-Channel enhancement mode power field effect transistors are produced using Mos-tech's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior swit ching performance, and wihstand high energy pulse in the avalanche and commutation mode. These devices are well

#### **Features**

- 3.0A, 100V,  $R_{DS(on)} = 0.1 \Omega @V_{GS} = 10 V$
- Low gate charge (typical 14 nC)
- Low Crss (typical 35 pF)
- · Fast switching
- · Improved dv/dt capability
- · RoHS Compliant.

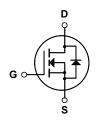
# **Applications**

- · High efficiency Switching DC/DC converters
- · Led device switching control

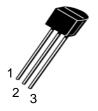


http://www.mtsemi.com

# **Simplified Schematic**



MARKING DIAGRAM & PIN ASSIGNMENT



1.GATE 2.DRAIN 3.SOURCE

TO-92

# **Absolute Maximum Ratings** (T<sub>A</sub> = 25 ℃ unless otherwise noted)

Symbol	Parameter		MT100N06	Units	
$V_{DSS}$	Drain-Source Voltage	rce Voltage		V	
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°	C)	3.0	Α	
	- Continuous (T <sub>C</sub> = 100°C)		1.0	Α	
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	10.0	Α	
V <sub>GSS</sub>	Gate-Source Voltage		± 20	V	
EAS	Single Pulsed Avalanche Energy (Note 2)		2.0	MJ	
I <sub>AR</sub>	Avalanche Current	(Note 1)	9.6	Α	
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	5.0	mJ	
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	6.0	V/ns	
P <sub>D</sub>	Power Dissipation (T <sub>A</sub> = 25°C) *		1.25	W	
	Power Dissipation (T <sub>C</sub> = 25°C)			W	
	- Derate above 25°C		0.4	W/°C	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C	
Tı	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C	
, 'L			300		

#### **Thermal Characteristics**

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		3.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		55	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		115	°C/W

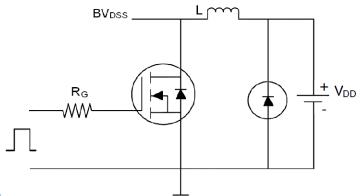
<sup>\*</sup> When mounted on the minimum pad size recommended (PCB Mount)

Symbol	Parameter	Test Condition	S	Min	Тур	Max	Unit
Off Cha	aracteristics						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		100			V
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C			0.09		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V				1	μΑ
		V <sub>DS</sub> = 80 V, T <sub>C</sub> = 125°C				10	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V			100	nA	
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = -20 V, V <sub>DS</sub> = 0 V				-100	nA
On Cha	aracteristics						
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA		1.0		2.9	V
R <sub>DS(on)</sub>	Static Drain-Source	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 2.0 A			0.10	0.11 0.13	
	On-Resistance	$V_{GS} = 4.5V, I_{D} = 1.5 A$			0.12		Ω
9 <sub>FS</sub>	Forward Transconductance	V = 30 V, I <sub>D</sub> = 2.0 A	(Note 4)		10		S
Dynam C <sub>iss</sub>	ic Characteristics Input Capacitance	V 25.4.4. 0.4.			180		pF
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz			20		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				10		pF
Curitala	ing Characteristics						•
t <sub>d(on)</sub>	ing Characteristics  Turn-On Delay Time	$V_{DD} = 50 \text{ V}, I_D = 1.5 \text{ A},$			6		ns
t <sub>r</sub>	Turn-On Rise Time				8		ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$R_G = 25 \Omega$			8		ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4, 5)			6		ns
Q <sub>g</sub>	Total Gate Charge	$V_{DS}$ = 80 V, $I_{D}$ = 1.2 A, $V_{GS}$ = 5 V (Not			5		nC
Q <sub>gs</sub>	Gate-Source Charge				1		nC
Q <sub>gd</sub>	Gate-Drain Charge		(Note 4, 5)		2		nC
	Source Diode Characteristics and Maximum Ratings  Maximum Continuous Drain-Source Diode Forward Current						
						3.0	Α
I <sub>S</sub>	Maximum Continuous Drain-Source Dic	ode Forward Current				3.0	A
I <sub>S</sub>	Maximum Continuous Drain-Source Dick Maximum Pulsed Drain-Source Diode F	ode Forward Current Forward Current				10.0	A A V
Drain-S I <sub>S</sub> I <sub>SM</sub> V <sub>SD</sub> t <sub>rr</sub>	Maximum Continuous Drain-Source Dic	ode Forward Current		  	   80		Α

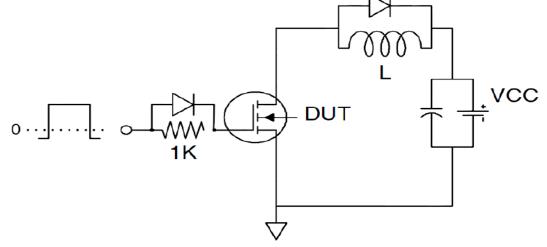
 $<sup>\</sup>label{eq:Notes:1} \textbf{Notes:} \\ \textbf{1. Repetitive Rating: Pulse width limited by maximum junction temperature } \\ \textbf{2. L} = 5.0mH, \textbf{I}_{AS} = 2.0A, \textbf{V}_{DD} = 25V, \textbf{R}_{G} = 25 \ \Omega, \textbf{Starting} \ \textbf{T}_{J} = 25^{\circ}\textbf{C} \\ \textbf{3. l}_{SD} \leq 19A, \textbf{didtd} \leq 300 \textbf{A}_{JB}, \textbf{V}_{DD} \leq \textbf{BV}_{DSS}, \textbf{Starting} \ \textbf{T}_{J} = 25^{\circ}\textbf{C} \\ \textbf{4. Pulse Test: Pulse width} \leq 300 \textbf{µs}, \textbf{Duty cycle} \leq 2\% \\ \textbf{5. Essentially independent of operating temperature} \\ \end{cases}$ 

# **Test Circuit**

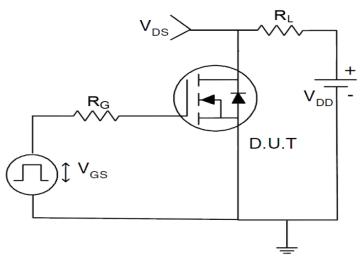
# 1) E<sub>AS</sub> test circuit

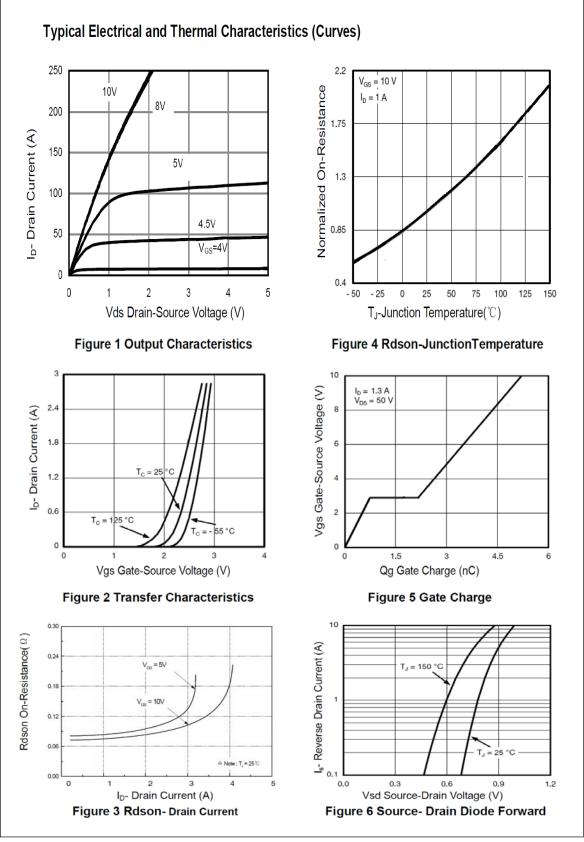


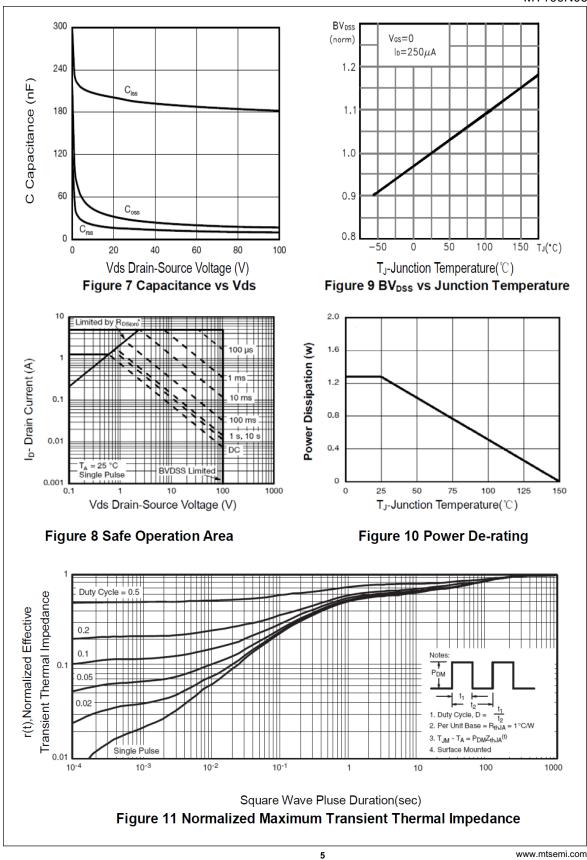
# 2) Gate charge test circuit

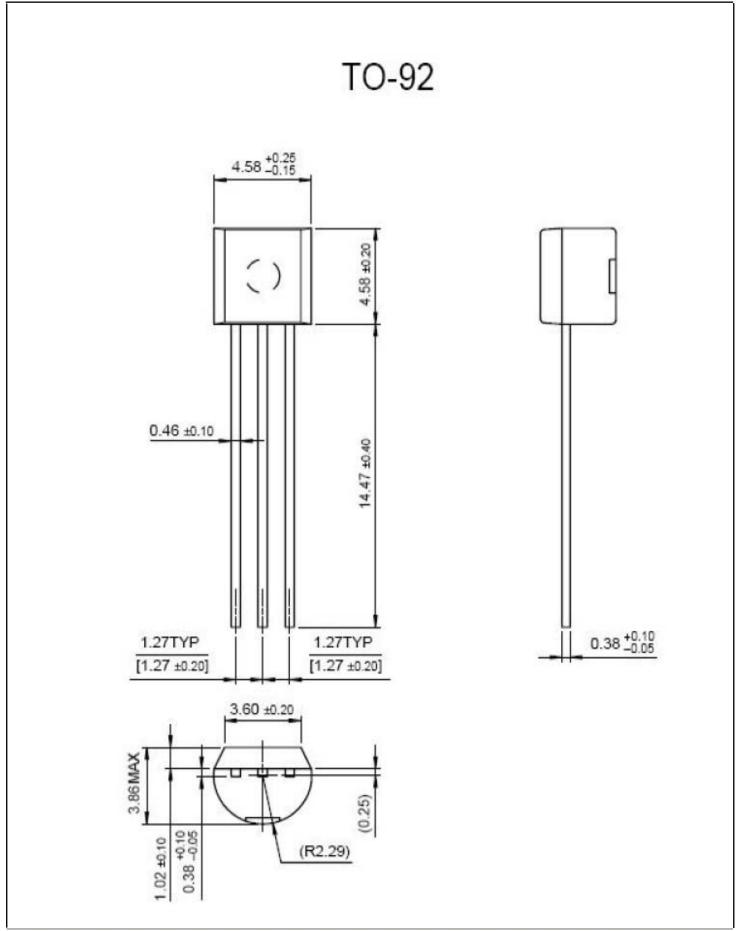


# 3) Switch Time Test Circuit









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